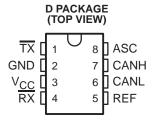
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- SN75LBC031 Meets Standard ISO/DIS 11898 (up to 500 k Baud)
- Driver Output Capability at 50 mA
- Wide Positive and Negative Input/output **Bus Voltage Range**
- **Bus Outputs Short-Circuit-Protected to Battery Voltage and Ground**
- **Thermal Shutdown**
- **Available in Q-Temp Automotive** 
  - HighRel Automotive Applications
  - Configuration Control/Print Support
  - Qualification to Automotive Standards

## description

The SN75LBC031 is a CAN transceiver used as an interface between a CAN controller and the physical bus for high speed applications of up to 500 kBaud. The device provides transmit capability to the differential bus and differential receive capability to the controller. The transmitter outputs (CANH and CANL), feature internal transition regulation to provide controlled symmetry resulting in low EMI emissions. Both



#### **TERMINAL FUNCTIONS**

| TERMINAL | DESCRIPTION                 |  |  |  |
|----------|-----------------------------|--|--|--|
| TX       | Transmitter input           |  |  |  |
| GND      | Ground                      |  |  |  |
| VCC      | Supply voltage              |  |  |  |
| RX       | Receiver output             |  |  |  |
| REF      | Reference output            |  |  |  |
| CANL     | Low side bus output driver  |  |  |  |
| CANH     | High side bus output driver |  |  |  |
| ASC      | Adjustable slope control    |  |  |  |

#### **FUNCTION TABLE**

| TX               | CANH         | CANL     | BUS STATE | RX |
|------------------|--------------|----------|-----------|----|
| L                | H L Dominant |          | L         |    |
| High or floating | Floating     | Floating | Recessive | Н  |

transmitter outputs are fully protected against battery short circuits and electrical transients that can occur on the bus lines. In the event of excessive device power dissipation the output drivers are disabled by the thermal shutdown circuitry at a junction temperature of approximately 160°C. The inclusion of an internal pullup resistor on the transmitter input ensures a defined output during power up and protocol controller reset. For normal operation at 500 kBaud the ASC terminal is open or tied to GND. For slower speed operation at 125 kBaud the bus output transition times can be increased to reduce EMI by connecting the ASC terminal to V<sub>CC</sub>. The receiver includes an integrated filter that suppresses the signal into pulses less than 30 ns wide.

The SN75LBC031 is characterized for operation from -40°C to 85°C. The SN65LBC031 is characterized for operation from -40°C to 125°C. The SN65LBC031Q is characterized for operation over the automotive temperature range of -40°C to 125°C.

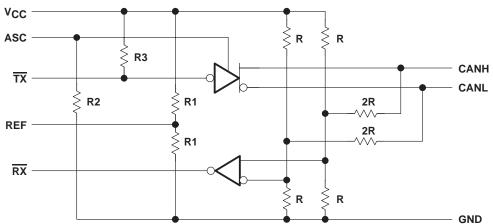


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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## logic diagram



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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Logic supply voltage, V <sub>CC</sub> (see Note 1)                             | 7 V                          |
|--|------------------------------|
| Bus terminal voltage   |                              |
| Input current at TX and ASC terminal, I <sub>1</sub>                           | ±10 mA                       |
| Input voltage at TX and ASC terminal, V <sub>I</sub>                           | 2 × V <sub>CC</sub>          |
| Operating free-air temperature range, T <sub>A</sub> : SN65LBC031, SN65LBC031Q | 40°C to125°C                 |
| SN75LBC031   | 40°C to 85°C                 |
| Operating juncation range, T <sub>J</sub>                                      | 40°C to 150°C                |
| Continuous total power dissipation at (or below) 25°C free-air temperature     | See Dissipation Rating Table |
| Storage temperature range, T <sub>sta</sub>                                    | 65°C to 150°C                |
| Case temperature for 10 sec T <sub>C</sub> , D package                         | 260°C                        |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values, except differential bus voltage, are measured with respect to GND.

#### **DISSIPATION RATING TABLE**

| PACKAGE | $T_{\mbox{\scriptsize A}} \le 25^{\circ}\mbox{\scriptsize C}$ POWER RATING | OPERATING FACTOR<br>ABOVE T <sub>C</sub> = 25°C | T <sub>C</sub> = 125°C<br>POWER RATING |
|---------|--|---|--|
| D       | 725 mW   | 5.8 mW/°C                                       | 145 mW                                 |

## **DISSIPATION DERATING CURVE**

### vs

### FREE-AIR TEMPERATURE

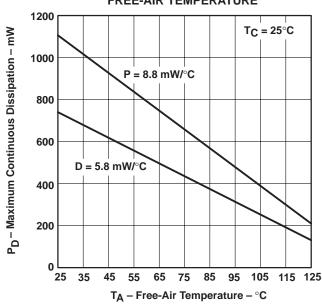


Figure 1

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## recommended operating conditions

|  |   | MIN | NOM | MAX  | UNIT |
|--|---|-----|-----|------|------|
| Logic supply voltage, V <sub>CC</sub>          |   | 4.5 | 5   | 5.5  | V    |
| Voltage at any bus terminal (separate          | /oltage at any bus terminal (separately or common mode), V <sub>I</sub> or V <sub>IC</sub> (see Note 3) |     |     |      | V    |
| High-level input voltage, VIH                  | TX  | 2   |     | VCC  | V    |
| Low-level input voltage, V <sub>IL</sub>       | TX  | 0   |     | 0.8  | V    |
| High level output current leve                 | Transmitter   |     |     | -50  | mA   |
| High-level output current, IOH                 | Receiver  |     |     | -400 | μΑ   |
| Low lovel output ourrent lov                   | Transmitter   |     |     | 50   | A    |
| Low-level output current, IOL                  | Receiver  |     |     | 1    | mA   |
| Operating free air temperature T.              | SN75LBC031  | -40 |     | 85   | °C   |
| Operating free-air temperature, T <sub>A</sub> | SN65LBC031, SN65LBC031Q   | -40 |     | 125  | -0   |

NOTES: 2. All voltage values, except differential bus voltage, are measured with respect to the ground terminal.

3. For bus voltages from -5 V to -2 V and 7 V to 20 V the receiver output is stable.

### **SYMBOL DEFINITION**

| DATA SHEET PARAMETER  | DEFINITION  |
|-----------------------|---|
| VO(CANHR)             | CANH bus output voltage (recessive state)         |
| VO(CANLR)             | CANL bus output voltage (recessive state)         |
| VO(CANHD)             | CANH bus output voltage (dominant state)          |
| VO(CANLD)             | CANL bus output voltage (dominant state)          |
| VO(DIFFR)             | Bus differential output voltage (recessive state) |
| V <sub>O(DIFFD)</sub> | Bus differential output voltage (dominant state)  |
| V <sub>I</sub> (ASC)  | Adjustable slope control input voltage            |

# electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

|                     | PARAMETER                             | TEST CONDITIONS           | MIN                  | TYP | MAX                  | UNIT |
|---------------------|---------------------------------------|---------------------------|----------------------|-----|----------------------|------|
| VO(REF)             | Reference source output voltage       | I <sub>REF</sub> = ±20 μA | 0.45 V <sub>CC</sub> |     | 0.55 V <sub>CC</sub> | V    |
| R <sub>O(REF)</sub> | Reference source output resistance    |                           | 5                    |     | 10                   | kΩ   |
| ICC(REC)            | Logic supply current, recessive state | See Figure 2, S1 closed   |                      | 12  | 20                   | mA   |
| ICC(DOM)            | Logic supply current, dominant state  | See Figure 2, ST Closed   |                      | 55  | 80                   | IIIA |

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# transmitter electrical characteristics over recommended ranges of supply and operating free-air temperature (unless otherwise noted)

|                        | PARAMETER                                     | TEST CONDITIONS                       | MIN  | TYP                | MAX  | UNIT |
|------------------------|---|---------------------------------------|------|--------------------|------|------|
| VO(CANHR)<br>VO(CANLR) | Output voltage (recessive state)              | See Figure 2, S1 open                 | 2    | 0.5V <sub>CC</sub> | 3    | V    |
| V <sub>O(DIFFR)</sub>  | Differential output voltage (recessive state) |                                       | -500 | 0                  | 50   | mV   |
| VO(CANHD)              | Output voltage (dominant state)               |                                       | 2.75 | 3.5                | 4.5  |      |
| VO(CANLD)              | Output voltage (dominant state)               | See Figure 2, S1 closed               | 0.5  | 1.5                | 2.25 | V    |
| VO(DIFFD)              | Differential output voltage (dominant state)  |                                       | 1.5  | 2                  | 3    |      |
| lu reso                | High-level input current (TX)                 | V <sub>IH</sub> = 2.4 V               |      | -100               | -185 | ^    |
| I <sub>IH</sub> (TX)   | righ-lever input current (1%)                 | VIH = VCC                             |      |                    | ±2   | μΑ   |
| l                      | High-level input current (ASC)                | V <sub>IH</sub> = 2.4 V               |      | 100                | 165  | μΑ   |
| IH(ASC)                | nigh-lever input current (ASC)                | V <sub>IH</sub> = V <sub>CC</sub>     |      | 200                | 340  | μА   |
| I <sub>IL(TX)</sub>    | Low-level input current $(\overline{TX})$     | V <sub>IL</sub> = 0.4 V               |      | -180               | -400 | μΑ   |
| IL(ASC)                | Low-level input current (ASC)                 | V <sub>IL</sub> = 0.4 V               |      | 15                 | 25   | μΑ   |
| C <sub>I(TX)</sub>     | TX input capacitance                          |                                       |      | 8                  |      | pF   |
| I <sub>O(ssH)</sub>    | CANH short circuit output current             | $V_{O(CANH)} = -2 V \text{ to } 20 V$ |      | -95                | -200 | mA   |
| I <sub>O(ssL)</sub>    | CANL short circuit output current             | V <sub>O(CANL)</sub> = 20 V to −2 V   |      | 140                | 250  | mA   |

NOTE 2: All voltage values, except differential bus voltage, are measured with respect to the ground terminal.

# transceiver dynamic characteristics over recommended operating free-air temperature range and $V_{CC}$ = 5 V

|                     | PARAMETER                      | TEST                               | CONDITIONS  | MIN | TYP | MAX | UNIT |
|---------------------|--------------------------------|------------------------------------|---|-----|-----|-----|------|
|                     | Loop time                      | See Figures 2 and 3,<br>S1 closed, | VI(ASC) = 0 V or open circuit,<br>S2 open             |     |     | 280 | ns   |
| <sup>t</sup> (loop) | Loop time                      | See Figures 2 and 3,<br>S1 closed, | V <sub>I</sub> (ASC) = V <sub>CC</sub> ,<br>S2 closed |     |     | 400 | ns   |
| CD (==)             | Differential-output slew rate  |                                    | V <sub>I</sub> (ASC) = 0 or open circuit,<br>S2 open  |     | 35  |     | V/μs |
| SR <sub>(RD)</sub>  | (recessive to dominant)        | See Figures 2 and 4,<br>S1 closed, | VI(ASC) = VCC,<br>S2 closed                           |     | 10  |     | V/μs |
| CD                  | Differential-output slew rate  | See Figures 2 and 4,<br>S1 closed, | V <sub>I</sub> (ASC) = 0 or open circuit,<br>S2 open  |     | 10  |     | V/μs |
| SR <sub>(DR)</sub>  | (dominant to recessive)        | See Figures 2 and 4,<br>S1 closed, | VI(ASC) = VCC,<br>S2 closed                           |     | 10  |     | V/μs |
| t <sub>d</sub> (RD) | Differential output delay time | San Figure 2                       | S1 closed   |     | 55  |     | ns   |
| t <sub>d(DR)</sub>  | Differential-output delay time | See Figure 2,                      | ST Closed   |     | 160 |     | ns   |
| tpd(RECRD)          | Receiver propagation delay     | See Figures 2 and 5                |   |     | 90  |     | ns   |
| tpd(RECDR)          | time                           | Gee rigules 2 and 5                |   |     | 55  |     | ns   |

NOTE 4: Receiver input pulse width should be >50 ns. Input pulses of <30 ns are suppressed.

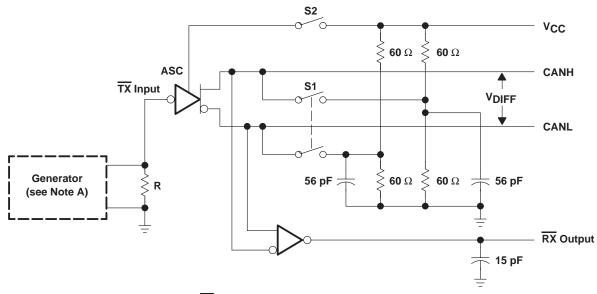
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# receiver electrical characteristics over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

|                     | PARAMETER  | TEST CONDITIONS  | MIN                    | TYP | MAX | UNIT |
|---------------------|--|--|------------------------|-----|-----|------|
| VIT(REC)            | Differential input threshold voltage for recessive state       | V <sub>IC</sub> = -2 V to 7 V                                  |                        |     | 500 | mV   |
| VIT(DOM)            | Differential input threshold voltage for dominant state        | VIC = -2 V 10 7 V  | 900                    |     |     | IIIV |
| V <sub>hys</sub>    | Recessive-dominant input hysteresis                            |  | 100                    | 180 |     | mV   |
| VOH(RX)             | High-level output voltage                                      | $V_{O(DIFF)} = 500 \text{ mV},$<br>$I_{OH} = -400 \mu\text{A}$ | V <sub>CC</sub> -0.5 V |     | VCC | V    |
| V <sub>OL(RX)</sub> | Low-level output voltage                                       | V <sub>O(DIFF)</sub> = 900 mV,<br>I <sub>OL</sub> = 1 mA       | 0                      |     | 0.5 | V    |
| rI(REC)             | CANH and CANL input resistance in recessive state              | dc, no load  | 5                      |     | 50  | kΩ   |
| rI(DIFF)            | Differential CANH and CANL input resistance in recessive state | dc, no load  | 10                     |     | 100 | kΩ   |
| Ci                  | CANH and CANL input capacitance                                |  |                        | 20  |     | pF   |
| C <sub>i(DHL)</sub> | Differential CANH and CANL input capacitance                   |  |                        | 10  | ·   | pF   |

NOTE 2: All voltage values, except differential bus voltage, are measured with respect to the ground terminal.

## PARAMETER MEASUREMENT INFORMATION



NOTE A: The input pulse is supplied to  $\overline{TX}$  by a generator having a  $t_f$  and  $t_f = 5$  ns.

Figure 2. Test Circuit

## PARAMETER MEASUREMENT INFORMATION

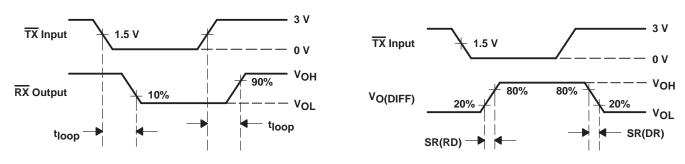
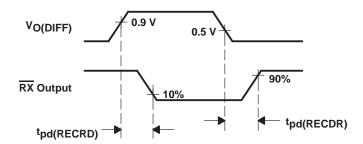


Figure 3. Loop Time

Figure 4. Slew Rate

NOTE A: The input pulse is supplied to  $\overline{TX}$  by a generator having a  $t_{\Gamma}$  and  $t_{f} = 5$  ns.



NOTE A: The input pulse is supplied as  $V_{DIFF}$  using CANH and CANL respectively by a generator having a  $t_r$  and  $t_f = 5$  ns.

Figure 5. Receiver Delay Times

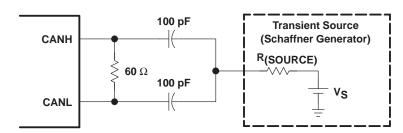


Figure 6. Transient Stress Capability Test Circuit

## PARAMETER MEASUREMENT INFORMATION

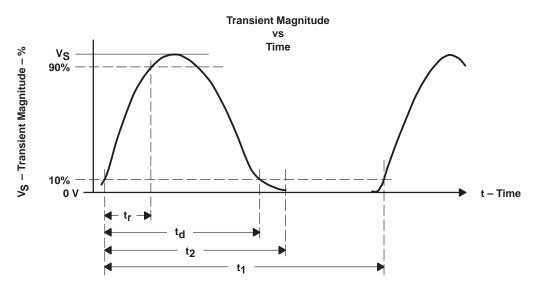


Figure 7. Transient Stress Capability Waveform

**Table 1. Test Circuit Results According to DIN 40839** 

| TEST PULSE | TRANSIENT<br>MAGNITUDE<br>VS | SOURCE<br>IMPEDANCE<br>RSOURCE | PULSE WIDTH<br>t <sub>d</sub><br>(see Note 5) | PULSE RISE<br>TIME, t <sub>r</sub><br>(see Note 6) | PULSE TIME,<br>t <sub>2</sub><br>(see Figure 7) | REPETITION<br>PERIOD, t <sub>1</sub><br>(see Figure 7) | NUMBER OF<br>PULSES |
|------------|------------------------------|--------------------------------|---|--|---|--|---------------------|
| 1          | –100 V                       | 10 Ω                           | 2 ms  | 1 μs   | 200 ms  | 5 s  | 5000                |
| 2          | 100 V                        | 10 Ω                           | 50 μs   | 1 μs   | 200 ms  | 5 s  | 5000                |
| 3a         | –150 V                       | 50 Ω                           | 0.1 μs  | 5 ns   | 100 μs  | 100 μs   | See Note 7          |
| 3b         | 100 V                        | 50 Ω                           | 0.1 μs  | 5 ns   | 100 μs  | 100 μs   | See Note 7          |
| 5          | 60 V                         | 1 Ω                            | 400 ms  | 5 ms   | _   | _  | 1                   |

NOTES: 5. Measured from 10% on rising edge to 10% on falling edge

- 6. Measured from 10% to 90% of pulse
- 7. Pulse package for a period of 3600 s, 10 ms pulse time, 90 ms stop time

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#### **APPLICATION INFORMATION** 5 V 💳 100 nF 3 120 $\Omega$ $\lesssim$ 10 k $\Omega$ 10 kΩ § 8 **VCC VCC** 8 ASC TL7705B **CANH** 7 SENSE SN75LBC031 RESIN RESET GND CANL REF **GND** $c_{\text{in}}$ TX REF RX 120 $\Omega$ 5 $\textbf{0.1}~\mu\textbf{F}$ 4 **CAN Microcontroller**

Figure 8. Typical SN75LBC031 Application

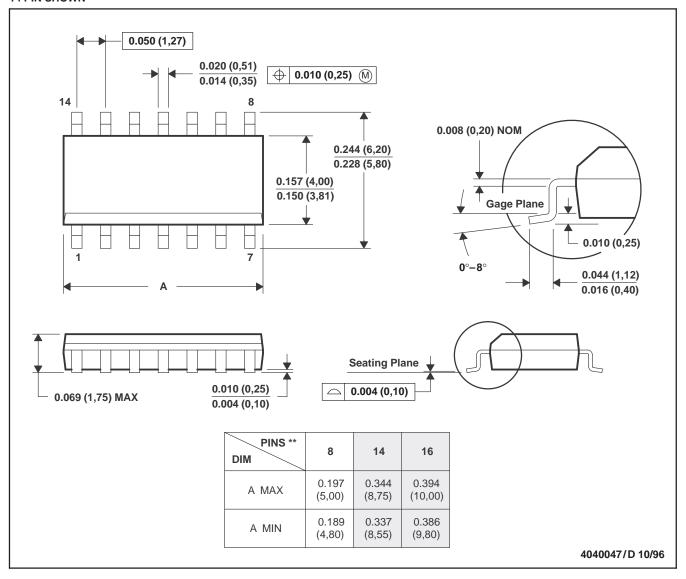
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### **MECHANICAL DATA**

## D (R-PDSO-G\*\*)

#### 14 PIN SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012

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